RF Ingress Measurements for Shielded Twisted Pair (STP) Cables from Automotive BCI Test

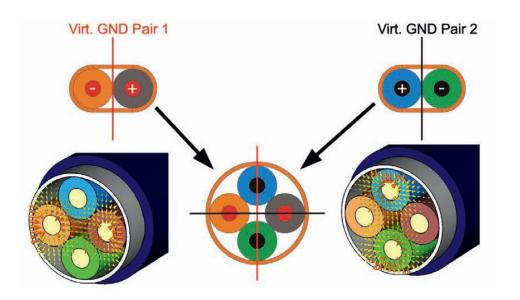
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- **Main Purpose:** Measurement of the induced MDI port voltage from a standard automotive radiated immunity bulk current injection (BCI) test with samples of shielded twisted pair (STP) automotive harness cable
 - The BCI test method is described in ISO 11452-4; this procedure is generally used only up to 400 MHz for testing RF immunity of automotive cable harnesses
 - Two different 2 meter cable samples: Single pair STP with H-MTD connectors, shielded star-quad with HSD connectors (only one pair active); both samples 2 meters long with only end connectors
 - Power cables not subjected to BCI; test setup intended to measure BCI ingress only on signal port
- Brief description of shielded star-quad cable
- Procedure and setup diagram for measurement of induced MDI port voltage from BCI test
- Measurement plots of MDI port voltage levels vs. frequency
 - Comparison of STP cables with coaxial cable and UTP cable
 - Comparison of STP cables and comparison with RF ingress of Cat 6A UTP at 10 V/meter (RF ingress measurement data from study group contribution cohen_3NGAUTO_01_022117)
- Main observation
 - The BCI-induced MDI port voltage on STP cables are significantly less than coax or UTP; similar to RF ingress level observed with Cat 6A UTP at 10 V/meter

Description of 4-Wire Shielded Star-Quad Cable



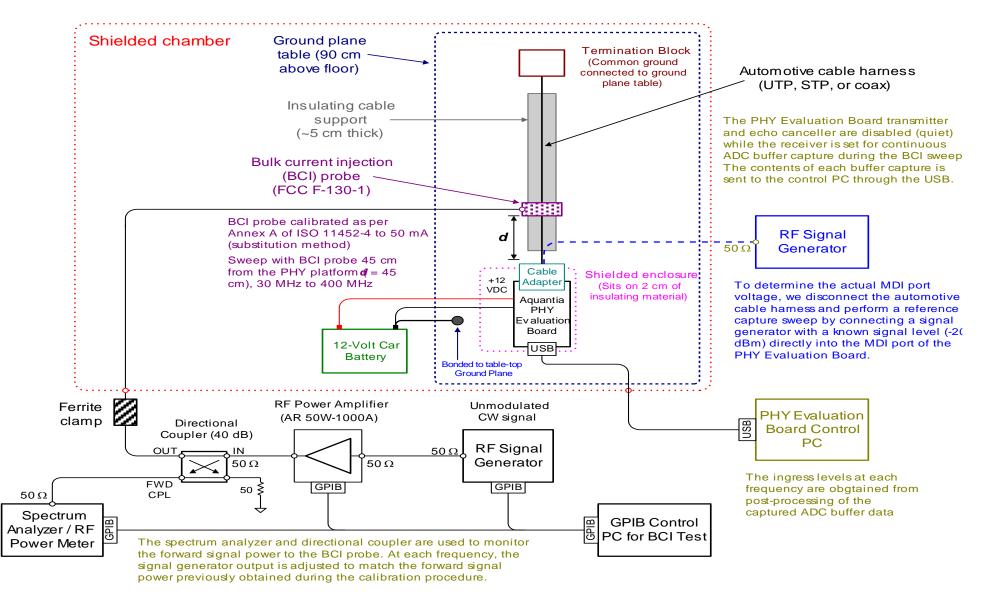


- More compact and cost-effective approach for implementing a 2-pair differential channel
- Star-quad cable uses enforced conductor cross-section symmetry (instead of tight twisting) to reduce crosstalk coupling between active pairs
- Each assigned differential pair has 100 Ω characteristic impedance
- Only one pair is used in the BCI ingress measurement test setup; can be used with a single signal pair
- For additional info on star-quad see mueller_3bp_01_0113

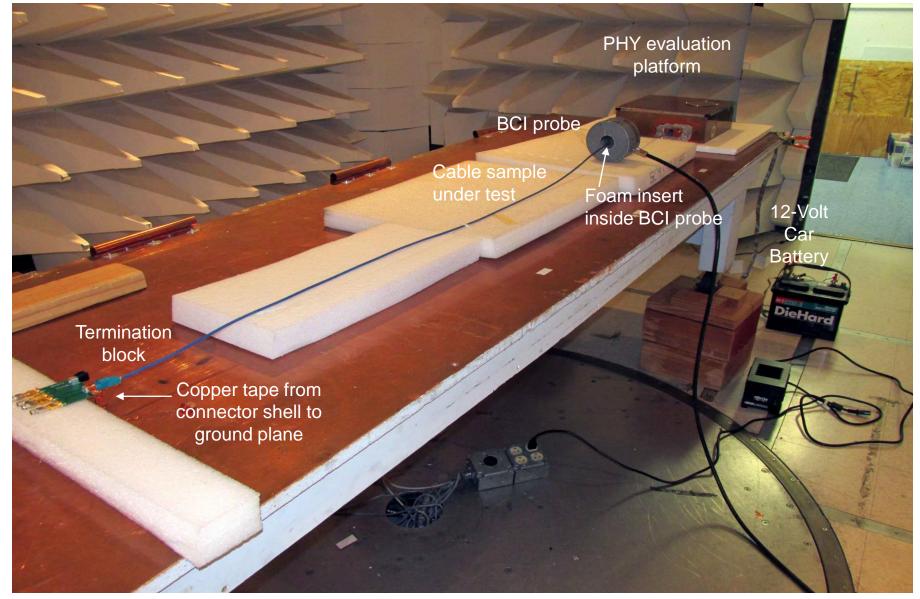
Procedure for Measurement of MDI Port Voltage from a BCI Test

- Perform the calibration procedure in Annex A of ISO 11452-4 to determine the required BCI probe input power to inject 50 mA of common-mode current at each frequency point (substitution method)
- Build the BCI test setup (page 5) with the automotive cable harness and connected to the far-end termination block; set the location of the BCI probe 45 cm from the MDI port
- Use the control PC to disable the evaluation platform PHY transmitter and echo canceller, set the PHY receiver gain blocks to known states, initiate continuous ADC buffer capture, and send the ADC buffer contents to the control PC over the USB
- Turn on the BCI drive amplifier and initiate the BCI frequency sweep; the sweep is from 33 MHz to 399 MHz at 2 MHz steps, dwell time of 2 seconds at each frequency point (after proper power leveling), test signal is an <u>unmodulated</u> CW signal
- When the BCI sweep is complete, apply post processing to the captured buffer data to determine the ADC capture level at each frequency point
- Connect an RF signal generator set at a known reference level (-20 dBm) to the MDI port and perform the same above sweep, buffer capture, and post processing to determine ADC capture level at each frequency point; this is the MDI port reference level sweep
- Determine the MDI port voltage from the BCI test by comparing and scaling the ADC capture levels from the BCI test to the corresponding data from the MDI port reference level sweep
- Scale the measured RF ingress voltage data to match a selected BCI test current condition template (e.g. GMW3097) with the difference between the test current level and test condition template and add any modulation level offset; plot the final result

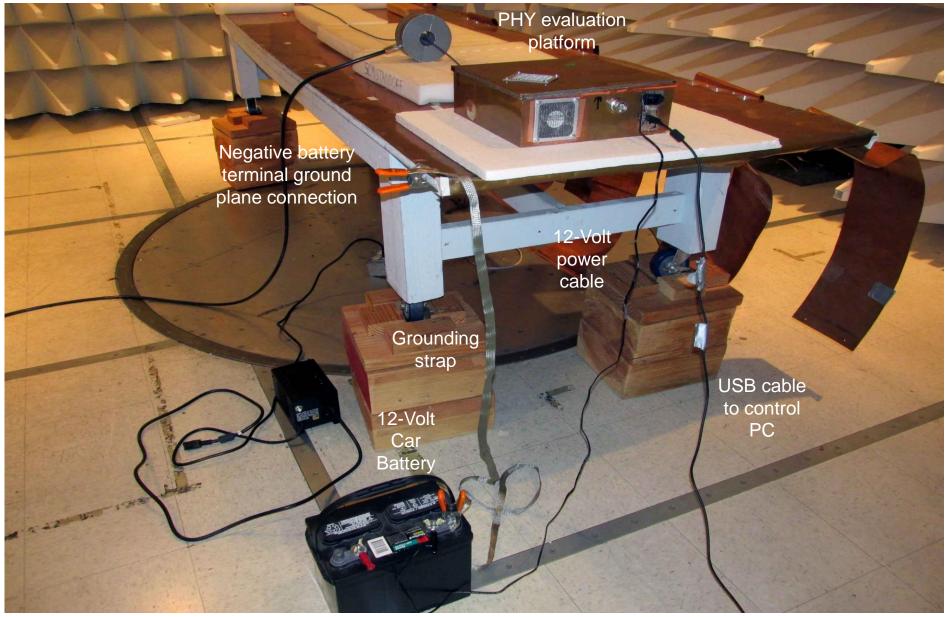
Setup Diagram for BCI RF Ingress Measurement on Automotive Cable



Test Setup for BCI RF Ingress Measurement on Automotive Cable (1)

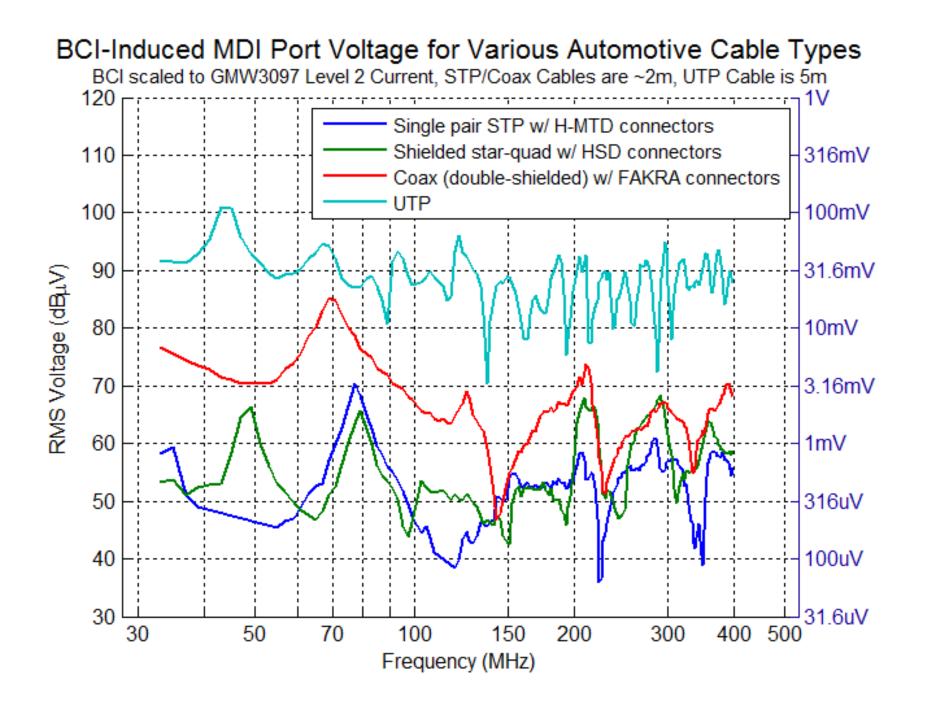


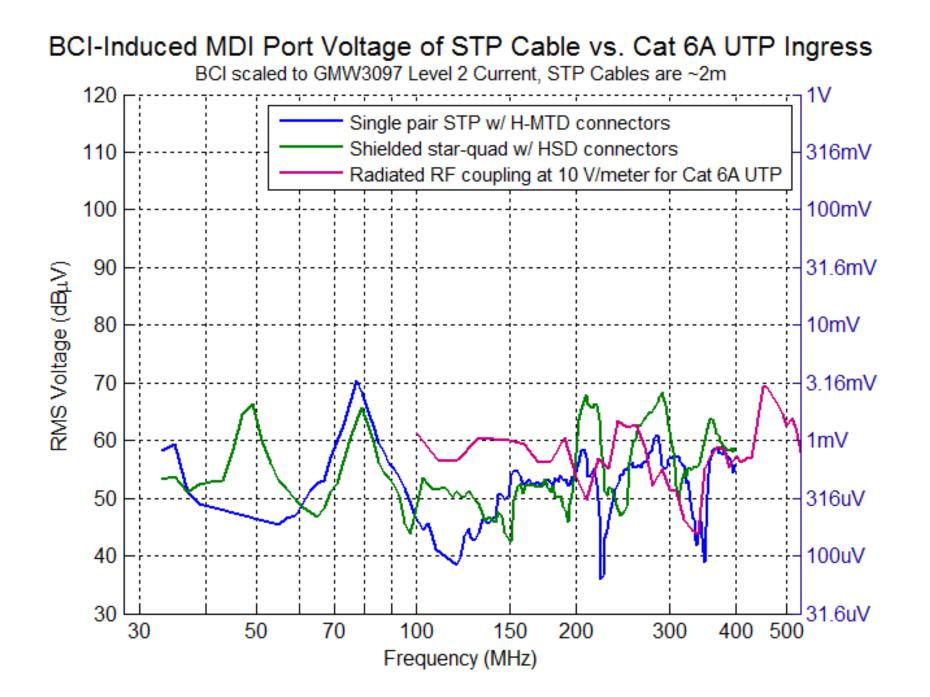
Test Setup for BCI RF Ingress Measurement on Automotive Cable (2)



Comments on Test Procedure and Test Setup

- Test setup revisions to last round of BCI ingress testing
 - Evaluation platform powered by a 12-Volt car battery with negative battery terminal connected to tabletop ground plane
 - 5 cm foam supports for cable standoffs (no wood used for standoffs)
 - Foam insert added around cable inside BCI probe to prevent cable from touching inside probe surface
- The BCI test current was set at 50 mA due to test equipment limitations
 - Use of reduced test currents simplifies test setup by allowing simple copper cable interconnects instead of fiber optics
 - This is permissible for this type of measurement since we can simply scale the final measured results to a desired test condition template (e.g. GMW3097, Figure 7)





Observations and Next Steps

Observations

- The observed RF ingress coupling from the STP cable samples is significantly less than double-shielded coaxial cable
- Star-quad with a single active pair has similar ingress level to single pair STP
- The observed RF ingress coupling from both STP cable samples is similar to the RF ingress level observed for Cat 6A UTP cabling in a 10 V/meter field
- The different peak/null pattern in the UTP measurement is due to the longer cable sample that was tested (5m for UTP vs. 1.9m for coaxial cable samples)
- Next steps
 - Perform RF ingress measurements on multi-segment connectorized channels

